

Notice of References Cited	Application/Control No. 10/664,981	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Chris C. Chu	Art Unit 2815	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,395,578	05-2002	Shin et al.	438/106
	B	US-6,137,164	10-2000	Yew et al.	257/686
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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